

Notice of References Cited	Application/Control No. 10/046,099	Applicant(s)/Patent Under Reexamination BEMENT ET AL.	
	Examiner Craig A. Renner	Art Unit 2652	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0101686 A1	08-2002	Bement et al.	360/245.3
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	60-055570	03-1985	Japan	Takahashi et al.	-----
	O	01-179286	07-1989	Japan	Oguchi et al.	-----
	P					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

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